High Granularity ECAL Study Using SLIC

Nigel Watson

- Introduction
- Software Tools
- Framework
- Results
- •Summary

[Simulations by J.Lilley, Birmingham/Durham summer student]

Monolithic Active Pixel Sensors

- Alternative to standard silicon diode pad detectors in ECAL
- CMOS process, more mainstream, potential to be
 - Less expensive
 - More performant
 - Better mechanical/thermal considerations
- Attempt to prove or disprove "MAPS-for-ECAL" concept over next 3 years

R&D Programme includes...

- Simulate effect on full detector performance in terms of PFLOW
- Device level modelling of response to e.m. showers, test against hardware
- 2 rounds of sensor fabrication and testing, including cosmics and sources
- e- beam test, check response in showers and single event upsets

Basic concept for MAPS





ECAL as a system

- Replace diode pad wafers and VFE ASICs with MAPS wafers
 - Mechanically very similar; overall design of structure identical
 - DAQ very similar; FE talks to MAPS not VFE ASICs
 - Both purely digital I/O, data rates within order of magnitude



- Aim for MAPS to be a "swap-in" option without impacting too much on most other ECAL design work
- Requires sensors to be glued/solder-pasted to PCB directly
 - No wirebonds; connections must be routed on sensor to pads above pixels
 - New technique needed which is part of our study

Potential advantages

- Slab thinner due to missing VFE ASICs
 - Improved effective Moliere radius (shower spread)
 - Reduced size (=cost) of detector magnet and outer subdetectors





- Thermal coupling to tungsten easier
 - Most heat generated in VFE ASIC or MAPS comparators
 - Surface area to slab tungsten sheet ~1cm² for VFE ASIC, ~100cm² for final MAPS
- **COST!** Standard CMOS should be cheaper than high resistivity silicon
 - No crystal ball for 2012 but roughly a factor of two different now
 - TESLA ECAL wafer cost was 90M euros; 70% of ECAL total of 133M euros

Calice, DESY, That assumed 3euros/cm² for 3000m² of processed silicon wafers 2005 Nigel Watson / Birmingham

Aims/Rationale

- Independent study of MAPS
- Try out evolving North American software suite
 - Event reconstruction framework
 - Easy to adapt geometry and implement MAPS
 SLIC
- Comparison of baseline SiD analogue Si to MAPS ECAL
- SLIC
 - Is well documented and supported <u>http://www.lcsim.org/software/slic</u>
- Gets geometry definition from LCDD format, typically generated from "compact" XML format using GeomConverter, attractive for MAPS study.
- Setting up SLIC is OK
 - Dependences CLHEP, GEANT4, LCPhys, LCIO, Xerces-C++, GDML, LCDD, ...

Software Framework

- This study using JAS3/org.lcsim
- Other prototype data analysis summer project (M.Stockton) using
 - George M.'s cleaned+calibrated LCIO files
 - Marlin
 - JAS3 + AIDA + Wired (for event display)



Conclusion: very easy to use this lightweight framework, well adapted to getting started quickly with little overhead



Particle leakage

- By looking at the first 14 layers in the simulations I created matching the 9 runs I had I could see how much of the event was contained in these layers
- For the 1 GeV runs it seems to be about 80% of the hits and 86% of the energy and no different for the run not at the centre of a wafer (100137)
- For the runs with increasing energy the amount measured drops but not by a constant amount (run 100123 and 100134 have energies 2GeV and 3GeV respectively)

Run	100121	100122	100123	100127	100128	160131	100132	100134	100137
% of hits	80.47	79.8	70.03	79.69	80.4	79.64	79.67	64.06	79.72
% of energy	86.25	85.83	80.68	85.81	86.28	85.81	85.72	77.33	85.74

The hits weighted by energy shows that the data does follow the same trend as the full detector simulation

CALICE-UK Meeting, Cambridge, 09/09/05

Position resolution

- Using the fit of the line through the 4 drift tubes I made a predicted impact point in each layer
- By then averaging all the hits in a layer and converting the position I could look at the position resolution in each layer
- As expected the rms increases later in the detector
- For the simulations that passed through the drift tubes in the layout of model TB05 (those at wafer 5) the rms was larger compared to the matching data runs but still showed the same trend of increasing later on in the detector
- I also noticed in the x position in data that there was an offset in alternate layers
- I looked at the simulation and the version of ecal I was using seemed to have several layers with offsets but this does not show up in the position resolution

CALICE-UK Meeting, Cambridge, 09/09/05



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Study

Definition of MAPS geomtry in SLIC
Estimating MIP thresholds
Longitudinal response of ECAL
Comparison of analogue/MAPS response
Non-Projective Geometry

Implementing MAPS in SiD

Based on SiD geometry 'cdcaug05', 20 layers @ 0.25cm W, 10 @ 0.5cm W

Adapt Si thickness to an epitaxial layer thickness of 5µm + 295µm substrate for MAPS

<!-- Electromagnetic calorimeter -->

<detector id="2" name="EMBarrel" type="CylindricalBarrelCalorimeter" readout="EcalBarrHits"> <dimensions inner r = "127.0*cm" outer z = "182.0*cm" \geq <layer repeat="20"> <slice material = "Tungsten" thickness = "0.25*cm" /> <slice material = "G10" thickness = "0.068*cm" /> <slice material = "Silicon" thickness = "0.032*cm" sensitive = "yes" /> <slice material = "Air" thickness = "0.025*cm" /</pre> </layer> <laver repeat="10"> <slice material = "Tungsten" thickness = "0.50*cm" /> <slice material = "G10" thickness = "0.068*cm" /> <slice material = "Silicon" thickness = "0.032*cm" sensitive = "yes" /> <slice material = "Air" thickness = "0.025*cm" /> </layer> </detector> Nigel Watson / Birmingham

<!-- Electromagnetic calorimeter -->

```
<detector id="2" name="EMBarrel"
type="CylindricalBarrelCalorimeter" readout="EcalBarrHits">
     <dimensions inner r = "127.0*cm" outer z = "182.0*cm" />
     <laver repeat="20">
      <slice material = "Tungsten" thickness = "0.25*cm" />
      <slice material = "G10" thickness = "0.07*cm" />
      <slice material = "Silicon" thickness = "0.0295*cm" />
      <slice material = "Silicon" thickness = "0.0005*cm" sensitive
           "yes" />
      '<slice material = "Air" thickness = "0.025*cm" />
     </layer>
     <layer repeat="10">
      <slice material = "Tungsten" thickness = "0.50*cm" />
      <slice material = "G10" thickness = "0.07*cm" />
      <slice material = "Silicon" thickness = "0.0295*cm" />
      <slice material = "Silicon" thickness = "0.0005*cm" sensitive
           "ves" />
      <slice material = "Air" thickness = "0.025*cm" />
     </layer>
  </detector>
                       Calice, DESY, 13-Oct-2005
```

MAPS projective segmentation

- 'cdcaug05' has a projective segmentation
- Use the number of 'bins' to give an average of 50x50 µm pixel pitch for MAPS.

```
<!-- Sensitive Detector readout segmentation --> <readouts>
```

<>

<readout name="EcalEndcapHits"> <segmentation type="ProjectiveZPlane" thetaBins="1024" phiBins="1024"/> <id>layer:7,system:6,barrel:3,theta:32:11,phi:11</id>

<>

<readout name="EcalBarrHits"> <segmentation type="ProjectiveCylinder" thetaBins="1000" phiBins="2000"/> <id>layer:7,system:6,barrel:3,theta:32:11,phi:11</id>

<>

<!-- Sensitive Detector readout segmentation --> <readouts>

<>

<>

<readout name="EcalEndcapHits"> <segmentation type="ProjectiveZPlane" thetaBins="95819" phiBins="40200"/> <id>layer:6,system:6,theta:18,barrel:32:3,phi:18</id>

<readout name="EcalBarrHits"> <segmentation type="ProjectiveCylinder" thetaBins="72800" phiBins="168239"/> <id>layer:6,system:6,theta:18,barrel:32:3,phi:18</id> </readout> <.....>

</readouts>
Watch out for the number of bits assigned to each field Nigel Watson's Birmingham McC for help!
Calice, DESY, 13-Oct-2005





MIP Signal

Estimate of MIP threshold SiD Baseline, 16mm² area cells MAPS 50x50 micron pixels



Raw Energy deposited in each pixel (MAPS) for 3GeV mu-

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Pixel Occupancy

MAPS concept requires binary readout... we need at most 1 hit per pixel or else lose information.



Select optimal pixel pitch from simulation studies

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Longitudinal response

Compare longitudinal shower development

Compare hits/layer for SiD and MAPS, to energy/layer for SiD





SiD ECAL Barrel Energy-Layer distribution for 10 GeV e-







SiD ECAL Barrel Energy-Layer distribution for 500 GeV e-



Comparing the Linearity



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Non-Projective Geometry

Non-projective geometry available 'sidaug05_np'

- Get constant pixel size
- Used more likely epitaxial layer thickness (15 micron)

SiD

<!-- Electromagnetic calorimeter -->

```
<detector id="2" name="EMBarrel"
    type="CylindricalBarrelCalorimeter"
    readout="EcalBarrHits">
          <dimensions inner r = "127.0*cm" outer z =
     "179.5*cm" />
          <layer repeat="30">
           <slice material = "Tungsten" thickness =
     "0.25*cm" />
           <slice material = "G10" thickness =
     "0.068*cm" />
           <slice material = "Silicon" thickness =
                      sensitive = "yes" />
     "0.032*cm"
           <slice material = "Air" thickness = "0.025*cm"
     \langle \rangle
          </layer>
                     30 layers constant
       </detector>
                     thickness, 0.25cm W
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```

MAPS

!-- Electromagnetic calorimeter -->

<detector id="2" name="EMBarrel" type="CylindricalBarrelCalorimeter" readout="EcalBarrHits"> <dimensions inner r = "127.0*cm" outer z = "179.5*cm" /> <laver repeat="30"> <slice material = "Tungsten" thickness = "0.25*cm" /> <slice material = "G10" thickness = "0.070*cm" / ><slice material = "Silicon" thickness = "0.0285*cm" /> <slice material = "Silicon" thickness = "0.0015*cm" sensitive = "yes" /> <slice material = "Air" thickness = "0.025*cm" $\langle \rangle$ </laver> </detector>Calice, DESY, 13-Oct-2005



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Preliminary results

Known problem below few GeV (artefact, plots not yet updated for this)



Future Plans

- Need to investigate PFLOW using fine granularity, advent of tools in Marlin a big help
- Implement more detailed simulations in Mokka (reduce interlayer gaps)
- Look for problems with MAPS concept any "showstoppers"?
- Plenty of time to prepare simulation for any beam test!

Other requirements

- Also need to consider power, uniformity and stability
 - Power must be similar (or better) that VFE ASICs to be considered
 - Main load from comparator; ~2.5 μ W/pixel when powered on
 - Investigate switching comparator; may only be needed for ~10ns
 - Would give averaged power of ~1nW/pixel, or 0.2W/slab
 - There will be other components in addition
 - VFE ASIC aiming for 100μ W/channel, or 0.4W/slab
 - Unfeasible for threshold to be set per pixel
 - Prefer single DAC to set a comparator level for whole sensor
 - Requires sensor to be uniform enough in response of each pixel
 - Possible fallback; divide sensor into e.g. four regions
 - Sensor will also be temperature cycled, like VFE ASICs
 - Efficiency and noise rate must be reasonably insensitive to temperature fluctuations
 - More difficult to correct binary readout downstream

Planned programme

- Two rounds of sensor fabrication
 - First with several pixel designs, try out various ideas
 - Second with uniform pixels, iterating on best design from first round
- Testing needs to be thorough
 - Device-level simulation to guide the design and understand the results
 - "Sensor" bench tests to study electrical aspects of design
 - Sensor-level simulation to check understanding of performance
 - "System" bench tests to study noise vs. threshold, response to sources and cosmics, temperature stability, uniformity, magnetic field effects, etc.
 - Physics-level simulation to determine effects on ECAL performance
- Verification in a beam test
 - Build at least one PCB of MAPS to be inserted into pre-prototype ECAL
 - Replace existing diode pad layer with MAPS layer
 - Direct comparison of performance of diode pads and MAPS